Positron Lifetime Measurement System

MADE IN JAPAN

Lifetime, Coincidence Doppler Broadening, and AMOC

SYSTEM

20181101

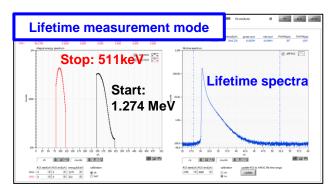
This is a device which integrates measuring equipment and power supply equipment necessary for positron annihilation method which can analyze molecular level nanoscale space structure. In <u>lifetime measurement</u>, high-speed pulse signals from two BaF₂ scintillators are captured by 3 Gsps board to calculate lifetime. In <u>CDB measurement</u>, coincidence is taken from two HPGe semiconductor detectors, and a two-dimensional histogram is generated from the crest value. Furthermore, <u>AMOC measurement</u> that correlate the lifetime and momentum are also realized by combining these modules.

Measurement Mode	 Lifetime Coincidence Doppler Broadening (CDB) Age-Momentum Correlation (AMOC)
ADC	Lifetime: 2 channels, 3Gsps, 8-bit CDB: 2 channels, 100Msps, 14-bit
Time Resolution	FWHM 192 ps (511 keV @ ²² Na, BaF ₂ scintillator) FWHM 160 – 190 ps (Certified standard quartz glass)
Energy Resolution	1.23 keV (512 keV @ ¹⁰⁶ Ru) 1.69 keV (1.33 MeV @ ⁶⁰ Co)
High Voltage Power Supply	2 channels, -4000V for PMT 2 channels, +5000V for HPGe semiconductor detector *Included Preamp power supply
Communication I/F	Ethernet (TCP/IP)

Application Software for Data acquisition, Instruction Manual

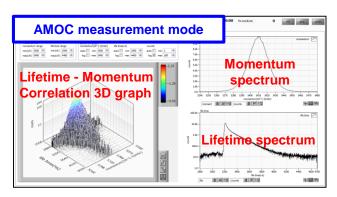
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Height: 32 cm, Width: 17 cm, Depth: 40cm

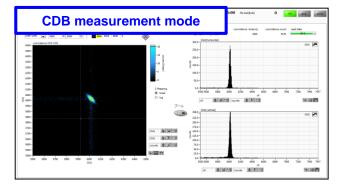


Accessories

Radiation source: 22Na, Sample: Polycarbonate



Sample: Silica





*Images is for illustration purpose.

Manufacture of Radiation and Radioactivity measurement devices

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^{*}Please note that contents may change without prior notice.